# **Small Signal MOSFET**

## 60 V, 340 mA, Single, N-Channel, SC-70

### **Features**

- ESD Protected
- Low R<sub>DS(on)</sub>
- Small Footprint Surface Mount Package
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant
- 2V Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable

## **Applications**

- Low Side Load Switch
- Level Shift Circuits
- DC-DC Converter
- Portable Applications i.e. DSC, PDA, Cell Phone, etc.

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Rating	Symbol	Value	Unit	
Drain-to-Source Voltage		V <sub>DSS</sub>	60	V
Gate-to-Source Voltage		V <sub>GS</sub>	±20	V
Drain Current (Note 1) Steady State	T <sub>A</sub> = 25°C T <sub>A</sub> = 85°C	I <sub>D</sub>	310 220	mA
t < 5 s	$T_A = 25$ °C $T_A = 85$ °C		340 240	
Power Dissipation (Note 1) Steady State t < 5 s		P <sub>D</sub>	280 330	mW
Pulsed Drain Current (t <sub>p</sub> = 10 μs)		I <sub>DM</sub>	1.4	Α
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
Source Current (Body Diode)	I <sub>S</sub>	250	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T <sub>L</sub>	260	°C
Gate-Source ESD Rating (HBM, Method 3015)	ESD	900	V	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	450	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 1)	$R_{\theta JA}$	375	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)

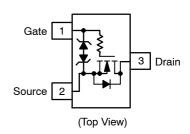


## ON Semiconductor®

## http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX (Note 1)
60 V	1.6 Ω @ 10 V	340 mA
	2.5 Ω @ 4.5 V	

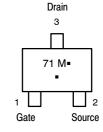
### SIMPLIFIED SCHEMATIC



# MARKING DIAGRAM & PIN ASSIGNMENT



SC-70/SOT-323 CASE 419 STYLE 8



71 = Device Code

M = Date Code

= Pb–Free Package

(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
2N7002WT1G	SC-70 (Pb-Free)	3000/Tape & Reel
2V7002WT1G	SC-70 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS	•						•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				71		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 150°C			15	μΑ
		V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			100	nA
		V <sub>DS</sub> = 50 V	T <sub>J</sub> = 150°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V			±10	μΑ
		V <sub>DS</sub> = 0 V, V	V <sub>GS</sub> = ±10 V			450	nA
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±5.0 V				150	nA
ON CHARACTERISTICS (Note 2)	•	•			•		•
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$	I <sub>D</sub> = 250 μA	1.0		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$R_{DS(on)}$ $V_{GS} = 10 \text{ V}, I_D = 500 \text{ mA}$ $V_{GS} = 4.5 \text{ V}, I_D = 200 \text{ mA}$			1.19	1.6	Ω
					1.33	2.5	1
Forward Transconductance	9FS	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 200 mA			530		mS
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				24.5		pF
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,}$ $V_{DS} = 20 \text{ V}$			4.2		
Reverse Transfer Capacitance	C <sub>RSS</sub>				2.2		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V; I <sub>D</sub> = 200 mA			0.7		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.1		
Gate-to-Source Charge	$Q_{GS}$				0.3		
Gate-to-Drain Charge	$Q_{GD}$				0.1		
SWITCHING CHARACTERISTICS, V <sub>GS</sub>	s = <b>V</b> (Note 3)			•			•
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DD}$ = 25 V, $I_{D}$ = 500 mA, $R_{G}$ = 25 $\Omega$			12.2		ns
Rise Time	t <sub>r</sub>				9.0		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				55.8		1
Fall Time	t <sub>f</sub>				29		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS	•		-	<u> </u>		-
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.8	1.2	V
		I <sub>S</sub> = 200 mA			0.7		1

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%
 Switching characteristics are independent of operating junction temperatures

## **TYPICAL CHARACTERISTICS**

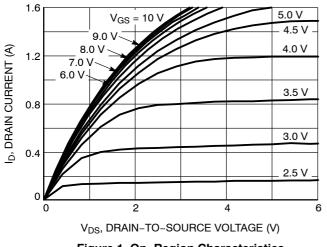


Figure 1. On-Region Characteristics

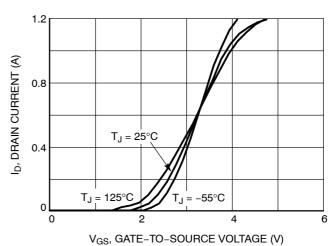


Figure 2. Transfer Characteristics

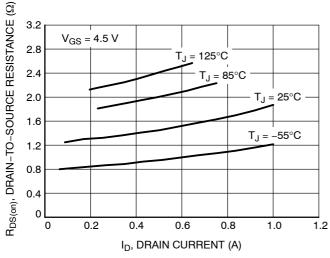


Figure 3. On–Resistance vs. Drain Current and Temperature

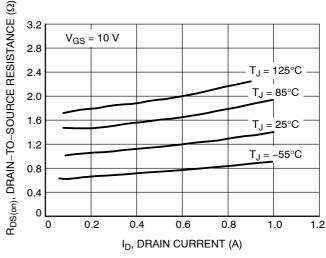


Figure 4. On-Resistance vs. Drain Current and Temperature

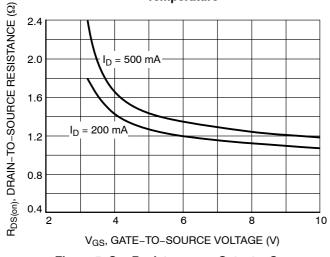


Figure 5. On-Resistance vs. Gate-to-Source Voltage

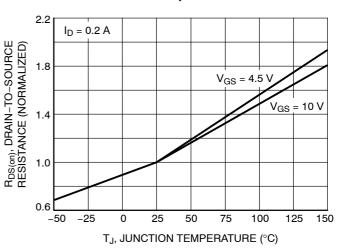


Figure 6. On–Resistance Variation with Temperature

## **TYPICAL CHARACTERISTICS**

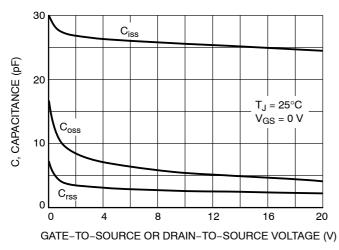


Figure 7. Capacitance Variation

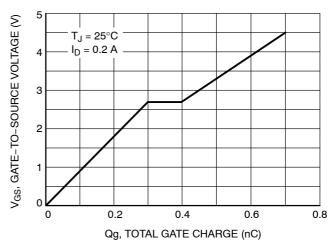


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

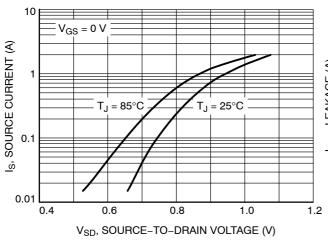


Figure 9. Diode Forward Voltage vs. Current

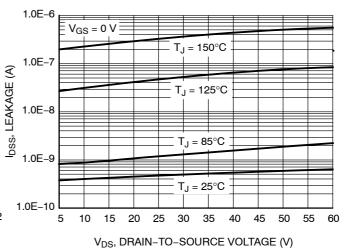
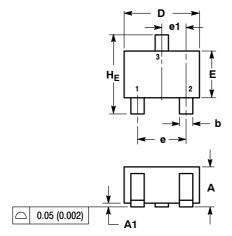


Figure 10. Drain-to-Source Leakage Current vs. Voltage

#### PACKAGE DIMENSIONS

SC-70 (SOT-323) CASE 419-04 ISSUE M



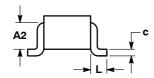
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.

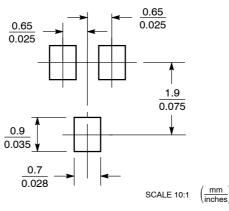
	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	MOM	MAX
Α	0.80	0.90	1.00	0.032	0.035	0.040
A1	0.00	0.05	0.10	0.000	0.002	0.004
A2		0.7 REF 0.028 REF			=	
b	0.30	0.35	0.40	0.012	0.014	0.016
С	0.10	0.18	0.25	0.004	0.007	0.010
D	1.80	2.10	2.20	0.071 0.083 0.0		
E	1.15	1.24	1.35	0.045	0.049	0.053
е	1.20	1.30	1.40	0.047	0.051	0.055
e1	0.65 BSC			0.026 BSC		
L	0.425 REF			0.017 REF		
HE	2.00	2.10	2.40	0.079	0.083	0.095

STYLE 8:

PIN 1. GATE 2 SOURCE DRAIN



### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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